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NUP2114 Series, SNUP2114

ESD Protection Diode

Low Capacitance ESD Protection for High Speed Data

The NUP2114 surge protection is designed to protect high speed data lines from ESD. Ultra-low capacitance and high level of ESD protection makes this device well suited for use in USB 2.0 applications.

Features

- Low Capacitance 0.8 pF
- Low Clamping Voltage
- Stand Off Voltage: 5 V
- Low Leakage
- ESD Rating of Class 3B (Exceeding 8 kV) per Human Body model and Class C (Exceeding 400 V) per Machine Model
- Protection for the Following IEC Standards: IEC 61000-4-2 Level 4 ESD Protection
- UL Flammability Rating of 94 V-0
- S Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- High Speed Communication Line Protection
- USB 2.0 High Speed Data Line and Power Line Protection
- Monitors and Flat Panel Displays
- MP3
- Gigabit Ethernet
- Notebook Computers
- Digital Video Interface (DVI) and HDMI

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit |
|---|------------------|--------------------------------|------|
| Operating Junction Temperature Range | TJ | -40 to +125 | °C |
| Storage Temperature Range | T _{stg} | -55 to +150 | °C |
| Lead Solder Temperature – Maximum (10 Seconds) | ΤL | 260 | °C |
| Human Body Model (HBM) Machine Model (MM) IEC 61000-4-2 Contact IEC61000-4-2 Air | ESD | 16000 400 13000 15000 | V |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

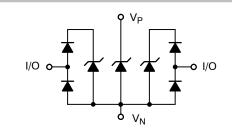
See Application Note AND8308/D for further description of survivability specs.



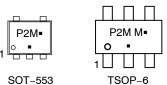
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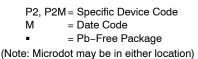
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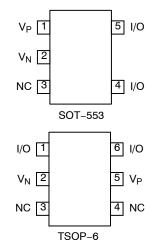


MARKING DIAGRAMS





PIN CONNECTIONS



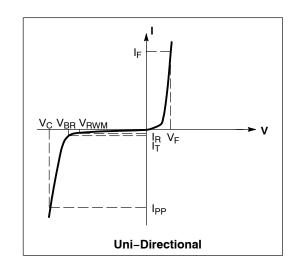
ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 4 of this data sheet.

ELECTRICAL CHARACTERISTICS

(T_A = 25°C unless otherwise noted)

| | - |
|------------------|--|
| Symbol | Parameter |
| I _{PP} | Maximum Reverse Peak Pulse Current |
| V _C | Clamping Voltage @ I _{PP} |
| V _{RWM} | Working Peak Reverse Voltage |
| I _R | Maximum Reverse Leakage Current @ V _{RWM} |
| V _{BR} | Breakdown Voltage @ I _T |
| Ι _Τ | Test Current |
| ١ _F | Forward Current |
| V _F | Forward Voltage @ I _F |
| P _{pk} | Peak Power Dissipation |
| С | Max. Capacitance @ $V_R = 0$ and f = 1.0 MHz |



*See Application Note AND8308/D for detailed explanations of datasheet parameters.

| Parameter | Symbol | Conditions | Min | Тур | Max | Unit |
|----------------------------|------------------|--|-----------------|------|-----|------|
| Reverse Working Voltage | V _{RWM} | (Note 1) | | | 5.0 | V |
| Breakdown Voltage | V _{BR} | I _T = 1 mA, (Note 2) | 5.5 | 7.5 | | V |
| Reverse Leakage Current | I _R | V _{RWM} = 5 V | | 0.01 | 1.0 | μA |
| Clamping Voltage | V _C | I _{PP} = 5 A (Note 3) | | 9.0 | | V |
| Clamping Voltage | V _C | I _{PP} = 8 A (Note 3) | | 10 | | V |
| Maximum Peak Pulse Current | I _{PP} | 8x20 μs Waveform | | | 12 | А |
| Junction Capacitance | CJ | V_R = 0 V, f = 1 MHz between I/O Pins and GND | | 0.8 | 1.0 | pF |
| Junction Capacitance | CJ | V _R = 0 V, f = 1 MHz between I/O Pins | | | 0.5 | pF |
| Clamping Voltage | V _C | @ I _{PP} = 1 A (Note 4) | | | 12 | V |
| Clamping Voltage | V _C | Per IEC 61000-4-2 (Note 5) | Figures 1 and 2 | | V | |

ELECTRICAL CHARACTERISTICS (TJ=25°C unless otherwise specified)

1. Surge protection devices are normally selected according to the working peak reverse voltage (V_{RWM}), which should be equal or greater than the DC or continuous peak operating voltage level.

2. V_{BR} is measured at pulse test current I_T.

3. Nonrepetitive current pulse (Pin 5 to Pin 2)

4. Surge current waveform per Figure 5.

5. Typical waveform. For test procedure see Figures 3 and 4 and Application Note AND8307/D.

6. Include S-prefix devices where applicable.

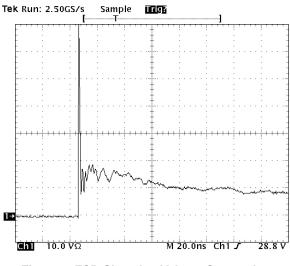
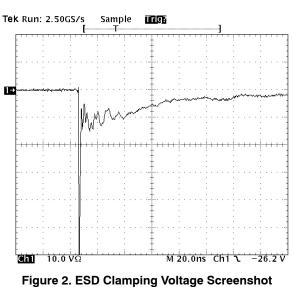


Figure 1. ESD Clamping Voltage Screenshot Positive 8 kV Contact per IEC61000-4-2

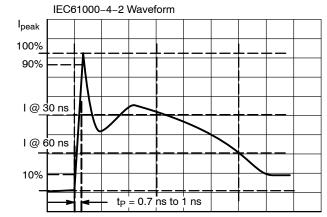


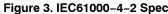
Negative 8 kV Contact per IEC61000–4–2

NUP2114 Series, SNUP2114

IEC 61000-4-2 Spec.

| Level | Test Volt- age (kV) | First Peak Current (A) | Current at 30 ns (A) | Current at 60 ns (A) |
|-------|------------------------|------------------------------|-------------------------|-------------------------|
| 1 | 2 | 7.5 | 4 | 2 |
| 2 | 4 | 15 | 8 | 4 |
| 3 | 6 | 22.5 | 12 | 6 |
| 4 | 8 | 30 | 16 | 8 |





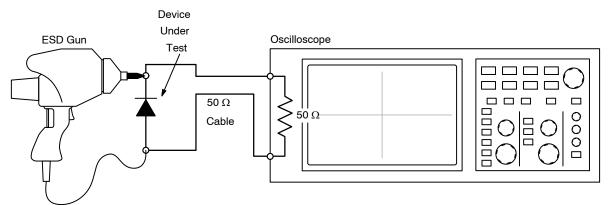


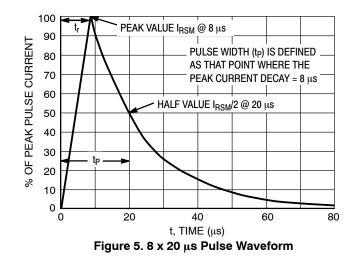
Figure 4. Diagram of ESD Test Setup

The following is taken from Application Note AND8308/D – Interpretation of Datasheet Parameters for ESD Devices.

ESD Voltage Clamping

For sensitive circuit elements it is important to limit the voltage that an IC will be exposed to during an ESD event to as low a voltage as possible. The ESD clamping voltage is the voltage drop across the ESD protection diode during an ESD event per the IEC61000–4–2 waveform. Since the IEC61000–4–2 was written as a pass/fail spec for larger

systems such as cell phones or laptop computers it is not clearly defined in the spec how to specify a clamping voltage at the device level. ON Semiconductor has developed a way to examine the entire voltage waveform across the ESD protection diode over the time domain of an ESD pulse in the form of an oscilloscope screenshot, which can be found on the datasheets for all ESD protection diodes. For more information on how ON Semiconductor creates these screenshots and how to interpret them please refer to AND8307/D.



NUP2114 Series, SNUP2114

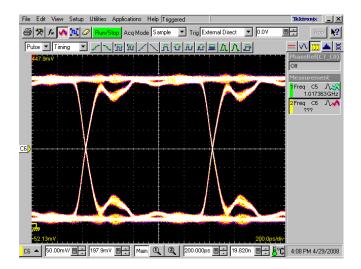


Figure 6. 500 MHz Data Pattern

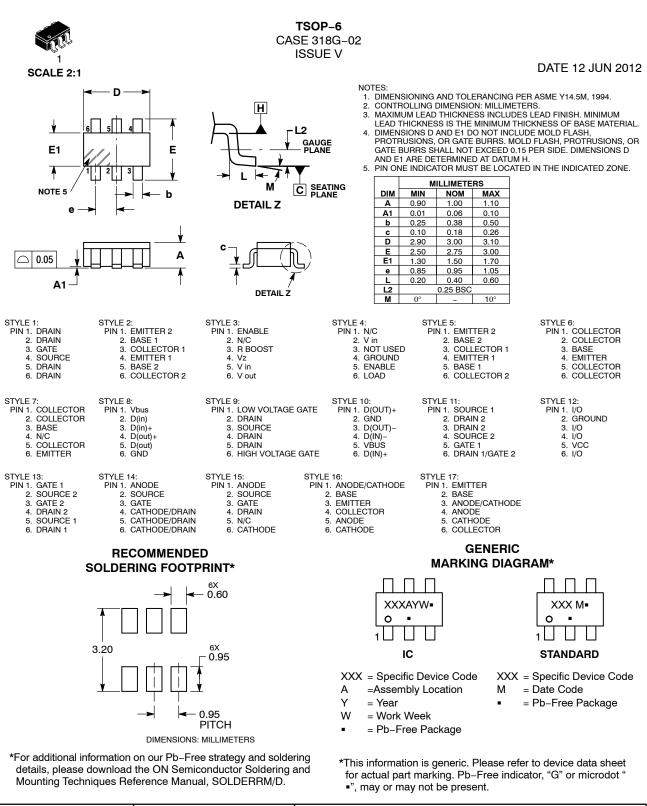
ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|-------------------|---------|----------------------|-----------------------|
| NUP2114UPXV5T1G | P2 | SOT-553 (Pb-Free) | 4,000 / Tape & Reel |
| NUP2114UCMR6T1G | P2M | TSOP-6 (Pb-Free) | 3,000 / Tape & Reel |
| SNUP2114UCMR6T1G* | P2M | TSOP-6 (Pb-Free) | 3,000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*S Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.





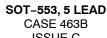
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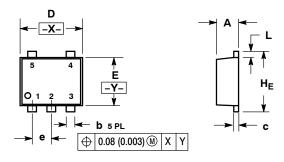


SCALE 4:1

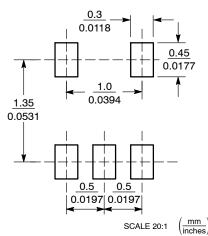


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RECOMMENDED **SOLDERING FOOTPRINT***



NOTES: 1. 2.

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TTES: DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETERS MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

| | MILLIMETERS | | | | INCHES | |
|-----|-------------|------|------|-----------|--------|-------|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX |
| Α | 0.50 | 0.55 | 0.60 | 0.020 | 0.022 | 0.024 |
| b | 0.17 | 0.22 | 0.27 | 0.007 | 0.009 | 0.011 |
| c | 0.08 | 0.13 | 0.18 | 0.003 | 0.005 | 0.007 |
| D | 1.55 | 1.60 | 1.65 | 0.061 | 0.063 | 0.065 |
| Е | 1.15 | 1.20 | 1.25 | 0.045 | 0.047 | 0.049 |
| е | 0.50 BSC | | | 0.020 BSC | | |
| L | 0.10 | 0.20 | 0.30 | 0.004 | 0.008 | 0.012 |
| HE | 1.55 | 1.60 | 1.65 | 0.061 | 0.063 | 0.065 |

GENERIC **MARKING DIAGRAM***

XXM•

XX = Specific Device Code M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present.

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

| STYLE 1: | STYLE 2: | STYLE 3: | STYLE 4: | STYLE 5: |
|-----------------------|-----------------|----------------|-----------------|--------------|
| PIN 1. BASE | PIN 1. CATHODE | PIN 1. ANODE 1 | PIN 1. SOURCE 1 | PIN 1. ANODE |
| 2. EMITTER | 2. COMMON ANODE | 2. N/C | 2. DRAIN 1/2 | 2. EMITTER |
| 3. BASE | 3. CATHODE 2 | 3. ANODE 2 | 3. SOURCE 1 | 3. BASE |
| 4. COLLECTOR | 4. CATHODE 3 | 4. CATHODE 2 | 4. GATE 1 | 4. COLLECTOR |
| 5. COLLECTOR | 5. CATHODE 4 | 5. CATHODE 1 | 5. GATE 2 | 5. CATHODE |
| STYLE 6: | STYLE 7: | STYLE 8: | STYLE 9: | |
| PIN 1. EMITTER 2 | PIN 1. BASE | PIN 1. CATHODE | PIN 1. ANODE | |
| 2. BASE 2 | 2. EMITTER | 2. COLLECTOR | 2. CATHODE | |
| 3. EMITTER 1 | 3. BASE | 3. N/C | 3. ANODE | |
| 4. COLLECTOR 1 | 4. COLLECTOR | 4. BASE | 4. ANODE | |
| 5. COLLECTOR 2/BASE 1 | 5. COLLECTOR | 5. EMITTER | 5. ANODE | |

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| В | ADDED NOMINAL VALUES AND UPDATED GENERIC MARKING DIAGRAM. REQ. BY HONG XIAO | 27 MAY 2005 |
| С | UPDATED DIMENSIONS D, E, AND HE. REQ. BY J. LETTERMAN. | 20 MAR 2013 |
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